

Report No.: BTEK240410003AE002

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FCC ID: 2AWYQ-BTDB19

TEST REPORT

Application No.: BTEK240410003AE

Version Number: V0

Applicant: QUANZHOU DAYTECH ELECTRONICS CO., LTD.

Address of Applicant: Hengdali Business Center, North Quanan Road, Jinjiang City, Quanzhou,

Fujian, China

Manufacturer: QUANZHOU DAYTECH ELECTRONICS CO., LTD.

Address of Manufacturer: Hengdali Business Center, North Quanan Road, Jinjiang City, Quanzhou,

Fujian, China

Factory: QUANZHOU DAYTECH ELECTRONICS CO., LTD.

Address of Factory: Hengdali Business Center, North Quanan Road, Jinjiang City, Quanzhou,

Fujian, China

Equipment Under Test (EUT):

EUT Name: wireless doorbell

Model No.: BT-DB19, BT004, BT006, BT008WH, BT-LC01, CB07, CB09

Please refer to section 3 of this report which indicates which model was

actually tested and which were electrically identical.

Trade Mark: N/A

Standard(s): 47 CFR Part 2 Subpart J Section 2.1093

Date of Receipt: 2024-04-10

Date of Test: 2024-04-10 to 2024-04-23

Date of Issue: 2024-04-24

Test Result: Pass*

Damon Su

EMC Laboratory Manager

ShenZhen BANTEK Testing Co.,Ltd.

Add: A5&A6, Building B1&B2, No.45 Gangtou Road, Bogang Community, Shajing Street

Bao'an District, Shenzhen, Guangdong, China 518104



^{*} In the configuration tested, the EUT complied with the standards specified above.



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Revision Record				
/ersion	Chapter	Date	Modifier	Remark
V0		2024-04-24		Original
	Q.	0	0	0
		2		

Authorized for issue by		
BIEK	Elma Kang	
0	Elma Yang / Project Engineer	
	Ción Car	
	Lion cai /Reviewer	

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General Information

3.1 Details of E.U.T.

Power supply:

DC 12V from basic zinc-manganese battery

Cable(s):

- / (

Frequency Range:

434MHz

Modulation Type:

ООК

Number of Channels:

Antenna Gain: Hardware Version -1 dBi

Software and

N/A

Firmware Version

N/A

Sample No.:

BTEK240410003AE-01

Remark: The information in this section is provided by the applicant or manufacturer, BANTEK is not

liable to the accuracy, suitability, reliability or/and integrity of the information.

Model No.: BT-DB19, BT004, BT006, BT008WH, BT-LC01, CB07, CB09

Only the model BT-DB19 was tested. According to the declaration from the applicant, the electrical circuit design, layout, components used, internal wiring and functions of other models are identical for the above models, with only difference on Model No.

3.2 Description of Support Units

Description	Manufacturer	Model No.	Serial No.
	///	132	

ShenZhen BANTEK Testing Co.,Ltd.

Add: A5&A6, Building B1&B2, No.45 Gangtou Road, Bogang Community, Shajing Street

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E-mail : Service@btek-lab.com

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3.3 Test Location

All tests were performed at:

Shenzhen BANTEK Testing Co., Ltd.,

A5&A6, Building B1&B2, No.45 Gangtou Road, Bogang Community, Shajing Street, Bao'an District,

Shenzhen, Guangdong, China 518103

Tel:0755-2334 4200 Fax: 0755-2334 4200

FCC Registration Number: 264293 Designation Number: CN1356 No tests were sub-contracted.

3.4 Deviation from Standards

None

3.5 Abnormalities from Standard Conditions

None

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4 Test Requirement

KDB447498 D01 General RF Exposure Guidance v06, Clause 4.3.1(a)

[(max. power of channel, including tune-up tolerance, mW) / (min. test separation distance, mm)] • $[\sqrt{f(GHz)}] \le 3.0$

Where

- -f(GHz) is the RF channel transmit frequency in GHz
- -Power and distance are rounded to the nearest mW and mm before calculation
- -The test exclusions are applicable only when the minimum test separation distance is \leq 50 mm, and for transmission frequencies between 100 MHz and 6 GHz. When the minimum test separation distance is < 5 mm, a distance of 5 mm according to 4.1 f) is applied to determine SAR test exclusion.

4.1Assessment Result

□ Passed
□

■ Not Applicable

E = EIRP - 20log D + 104.8

where:

E = electric field strength in $dB\mu V/m$,

EIRP = equivalent isotropic radiated power in dBm

D = specified measurement distance in meters.

Note: Field strength (max) (dBuV/m) is reference to BTEK240410003AE001.

Туре	Frequency (MHz)	Field strength(max) (dBuV/m)	Maximum EIRP (dBm)	Maximum EIRP (mW)	Calculating data	Limit	Result
OOK	434	61.50	-33.76	0.00042	0.000055	3.0	Pass

Note: The exposure evaluation safety distance is 5mm.

-- End of the Report -

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